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TAPE AND REEL TYPE LED LAMPS

LDGM4341/TRS-X

DATA SHEET

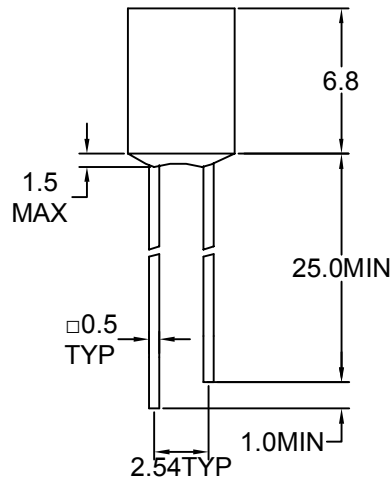
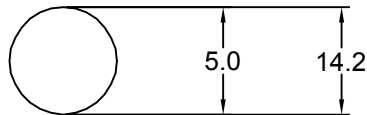
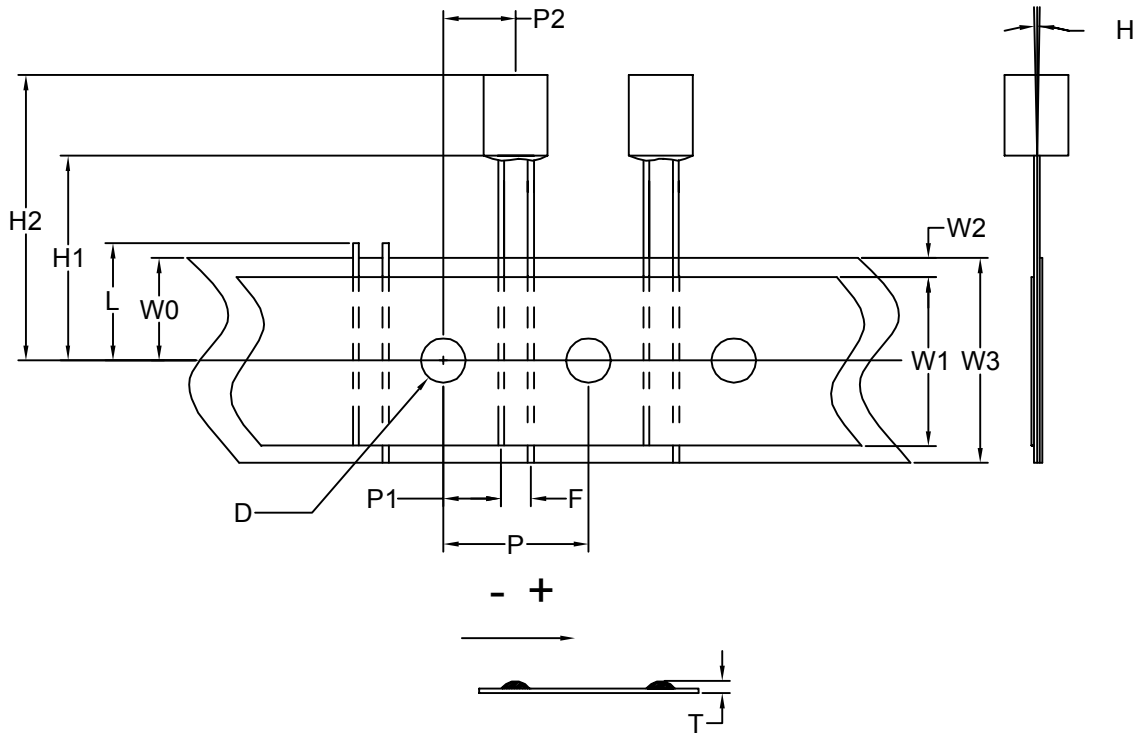
DOC. NO : QW0905-LDGM4341/TRS-X

REV : A

DATE : 29 - Sep - 2005



Package Dimensions



Note : 1.All dimension are in millimeter tolerance is $\pm 0.25\text{mm}$ unless otherwise noted.
2.Specifications are subject to change without notice.



Absolute Maximum Ratings at Ta=25

Parameter	Symbol	Ratings	UNIT
		DGM	
Forward Current	IF	30	mA
Peak Forward Current Duty 1/10@10KHz	IFP	100	mA
Power Dissipation	PD	120	mW
Reverse Current @5V	Ir	50	μ A
Electrostatic Discharge	ESD	150	V
Operating Temperature	Topr	-20 ~ +80	
Storage Temperature	Tstg	-30 ~ +100	
Soldering Temperature	Tsol	Max 260 for 5 sec Max (2mm from body)	

Typical Electrical & Optical Characteristics (Ta=25)

PART NO	MATERIAL	COLOR		Peak wave length Pnm	Dominant wave length Dnm	Spectral halfwidth nm	Forward voltage @20mA(V)		Luminous intensity @20mA(mcd)		Viewing angle 2 1/2 (deg)
		Emitted	Lens				Typ.	Max.	Min.	Typ.	
LDGM4341/TRS-X	InGaN/GaN	Green	Green Transparent	518	525	36	3.5	4.0	550	1040	88

Note : 1. The forward voltage data did not including ±0.1V testing tolerance.
 2. The luminous intensity data did not including ±15% testing tolerance.

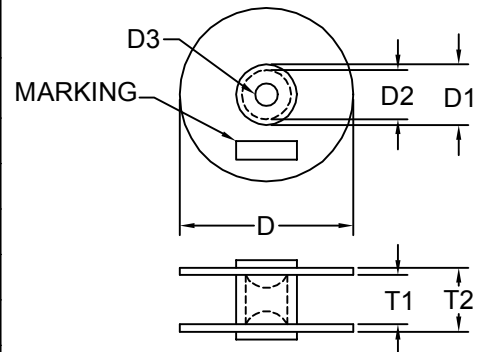


Dimensions Symbol Information

SYMBOL ITEMS	OPTION CODE	SYMBOL	SPECIFICATIONS			
			Minimum		Maximum	
			mm	inch	mm	inch
Tape Feed Hole Diameter	-----	D	3.8	0.15	4.2	0.17
Component Lead Pitch	-----	F	2.3	0.09	3.0	0.12
Front-To-Rear Deflection	-----	H	-----	-----	2.0	0.08
Feed Hole To Bottom Of Component	TRS-1	H1	17.5	0.69	18.5	0.73
	TRS-2		21.5	0.85	22.5	0.89
	TRS-3		25.5	1.0	26.5	1.04
	TRS-5		22.5	0.89	23.5	0.93
	TRS-6		19.9	0.78	20.9	0.82
	TRS-7		24.0	0.94	25.0	0.98
	TRS-8		24.5	0.96	25.5	1.0
	TRS-9		19.0	0.75	20.0	0.79
	TRS-10		18.0	0.72	19.4	0.76
	TRS-11		21.0	0.84	22.0	0.88
	TRS-12		20.5	0.81	21.5	0.85
	TRS-13		18.0	0.72	19.0	0.76
	TRS-14		26.5	1.04	27.5	1.08
	Feed Hole To Overall Component Height		-----	H2	-----	-----
Lead Length After Component Height	-----	L	W0		11.0	0.43
Feed Hole Pitch	-----	P	12.4	0.49	13.0	0.51
Lead Location	-----	P1	4.4	0.17	5.8	0.23
Center Of Component Location	-----	P2	5.1	0.2	7.7	0.3
Overall Taped Package Thickness	-----	T	-----	-----	1.42	0.06
Feed Hole Location	-----	W0	8.5	0.33	9.75	0.38
Adhesive Tape Width	-----	W1	14.5	0.57	15.5	0.61
Adhesive Tape Position	-----	W2	0	0	4.0	0.16
Tape Width	-----	W3	17.5	0.69	19.0	0.75

REMARK: TRS=Tape And Reel Straight Leads

Dimensions Symbol Information					Package Dimensions		
Description	Symbol	Specification				mm	inch
		minimum		maximum			
		mm	inch	mm	inch		
Reel Diameter	D	78.2	3.08	380	14.96		
Core Diameter	D1	34.9	1.37	102	4.02		
Hub Recess Inside Diameter	D2	28.6	1.13	88.0	3.46		
Arbor Hole Diameter	D3	13.8	0.54	38.1	1.5		
Overall Reel Thickness	T2	-----	-----	57.2	2.25		
Inside Reel Flange Thickness	T1	30.0	1.18	50.0	1.97		
Package		Quantity/Reel				Order Increments	
LDGM4341/TRS-X		1000PCS					





Typical Electro-Optical Characteristics Curve

DGM CHIP

Fig.1 Forward current vs. Forward Voltage

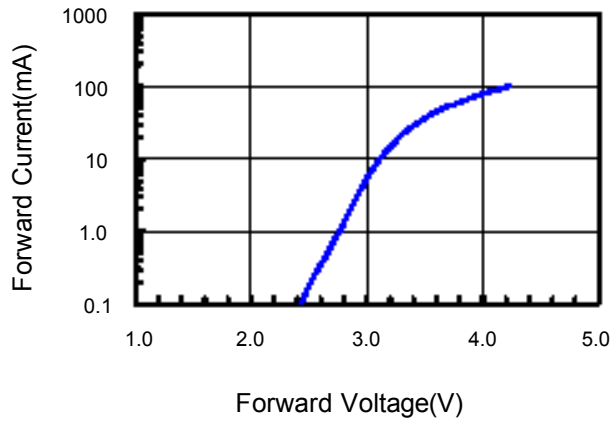


Fig.2 Relative Intensity vs. Forward Current

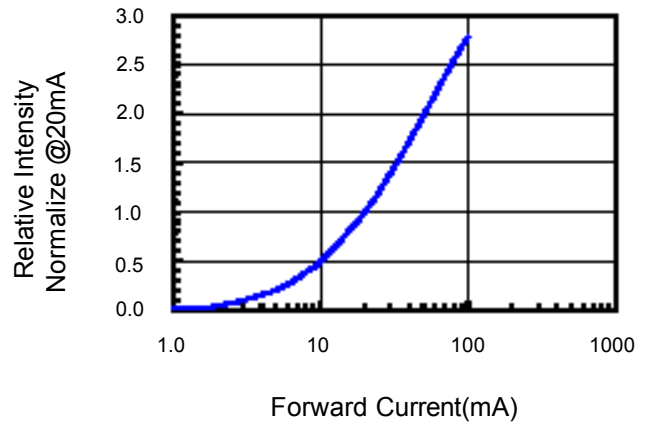


Fig.3 Forward Voltage vs. Temperature

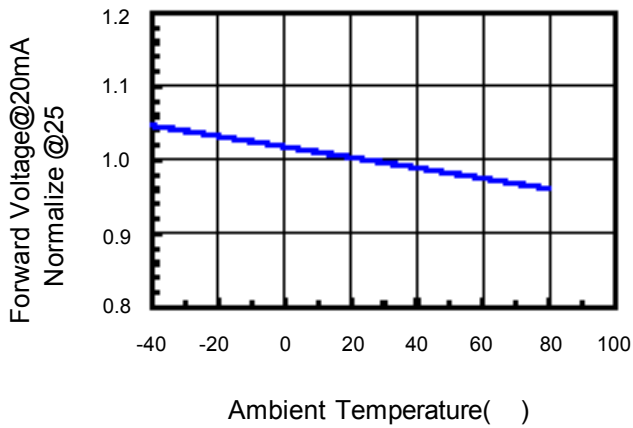


Fig.4 Relative Intensity vs. Temperature

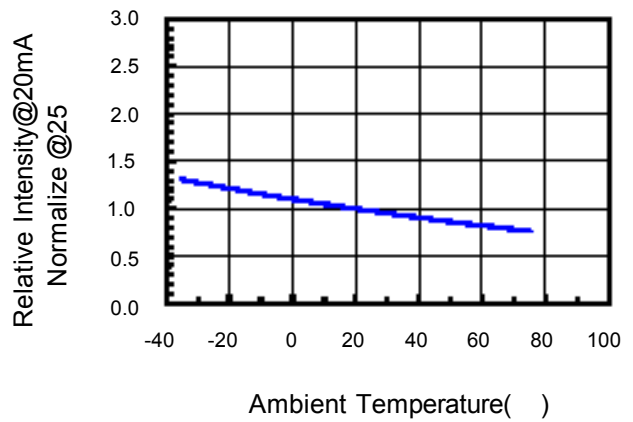
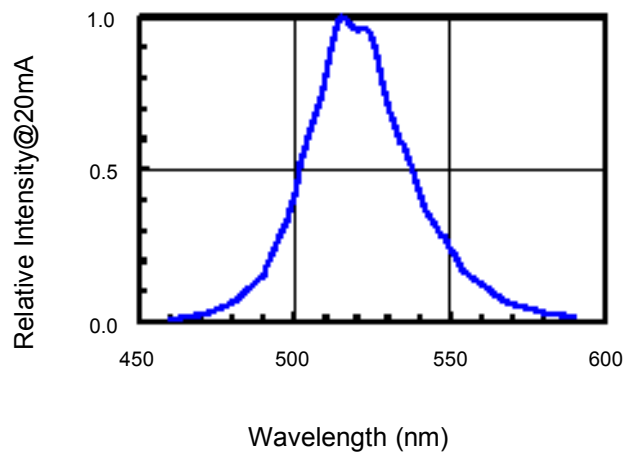


Fig.5 Relative Intensity vs. Wavelength



**Reliability Test:**

Test Item	Test Condition	Description	Reference Standard
Operating Life Test	1.Under Room Temperature 2.If=20mA 3.t=1000 hrs (-24hrs, +72hrs)	This test is conducted for the purpose of determining the resistance of a part in electrical and thermal stressed.	MIL-STD-750: 1026 MIL-STD-883: 1005 JIS C 7021: B-1
High Temperature Storage Test	1.Ta=105 ±5 2.t=1000 hrs (-24hrs, +72hrs)	The purpose of this is the resistance of the device which is laid under condition of high temperature for hours.	MIL-STD-883:1008 JIS C 7021: B-10
Low Temperature Storage Test	1.Ta=-40 ±5 2.t=1000 hrs (-24hrs, +72hrs)	The purpose of this is the resistance of the device which is laid under condition of low temperature for hours.	JIS C 7021: B-12
High Temperature High Humidity Test	1.Ta=65 ±5 2.RH=90%~95% 3.t=240hrs ±2hrs	The purpose of this test is the resistance of the device under tropical for hours.	MIL-STD-202:103B JIS C 7021: B-11
Thermal Shock Test	1.Ta=105 ±5 & -40 ±5 (10min) (10min) 2.total 10 cycles	The purpose of this is the resistance of the device to sudden extreme changes in high and low temperature.	MIL-STD-202: 107D MIL-STD-750: 1051 MIL-STD-883: 1011
Solder Resistance Test	1.T.Sol=260 ±5 2.Dwell time= 10 ±1sec.	This test intended to determine the thermal characteristic resistance of the device to sudden exposures at extreme changes in temperature when soldering the lead wire.	MIL-STD-202: 210A MIL-STD-750: 2031 JIS C 7021: A-1
Solderability Test	1.T.Sol=230 ±5 2.Dwell time=5 ±1sec	This test intended to see soldering well performed or not.	MIL-STD-202: 208D MIL-STD-750: 2026 MIL-STD-883: 2003 JIS C 7021: A-2